



ALPHA & OMEGA
SEMICONDUCTOR

AO4803A

30V Dual P-Channel MOSFET

General Description

The AO4803A uses advanced trench technology to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use as a load switch or in PWM applications.

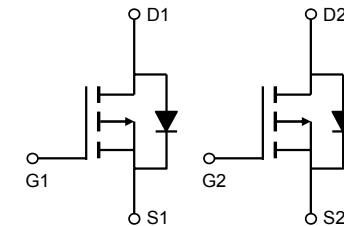
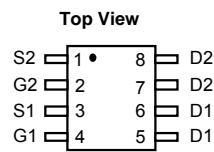
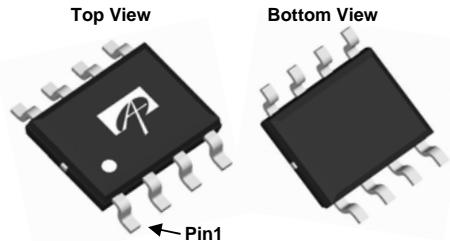
Product Summary

| | |
|-------------------------------------|--------|
| V_{DS} | -30V |
| I_D (at $V_{GS}=-10V$) | -5A |
| $R_{DS(ON)}$ (at $V_{GS}=-10V$) | < 46mΩ |
| $R_{DS(ON)}$ (at $V_{GS} = -4.5V$) | < 74mΩ |

100% UIS Tested
100% R_g Tested



SOIC-8



Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | Maximum | Units |
|--|------------------|------------|-------|
| Drain-Source Voltage | V_{DS} | -30 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current ^A | I_D | -5 | A |
| Current ^B | | -4 | |
| Pulsed Drain Current ^C | I_{DM} | -30 | |
| Avalanche Current ^C | I_{AS}, I_{AR} | 17 | A |
| Avalanche energy $L=0.1\text{mH}$ ^C | E_{AS}, E_{AR} | 14 | mJ |
| Power Dissipation ^B | P_D | 2 | W |
| Power Dissipation ^B | | 1.3 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | °C |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|--|-----------------|-----|------|-------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | 48 | 62.5 | °C/W |
| Maximum Junction-to-Ambient ^D | | 74 | 110 | °C/W |
| Maximum Junction-to-Lead | $R_{\theta JL}$ | 35 | 40 | °C/W |

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|------|----------|-----------|------------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=-250\mu\text{A}, V_{GS}=0\text{V}$ | -30 | | | V |
| $I_{\text{DS}(\text{SS})}$ | Zero Gate Voltage Drain Current | $V_{DS}=-30\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | | -1 -5 | μA |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$ | | | ± 100 | nA |
| $V_{\text{GS}(\text{th})}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=-250\mu\text{A}$ | -1.5 | -2 | -2.5 | V |
| $I_{\text{D}(\text{ON})}$ | On state drain current | $V_{GS}=-10\text{V}, V_{DS}=-5\text{V}$ | -30 | | | A |
| $R_{\text{DS}(\text{ON})}$ | Static Drain-Source On-Resistance | $V_{GS}=-10\text{V}, I_D=-5\text{A}$ $T_J=125^\circ\text{C}$ | | 32 48 | 46 68 | $\text{m}\Omega$ |
| | | $V_{GS}=-4.5\text{V}, I_D=-4\text{A}$ | | 51 | 74 | $\text{m}\Omega$ |
| | | $V_{DS}=-5\text{V}, I_D=-5\text{A}$ | | 13 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=-1\text{A}, V_{GS}=0\text{V}$ | | -0.7 | -1 | V |
| I_S | Maximum Body-Diode Continuous Current | | | | -2.5 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}, V_{DS}=-15\text{V}, f=1\text{MHz}$ | 415 | 520 | 625 | pF |
| C_{oss} | Output Capacitance | | 70 | 100 | 130 | pF |
| C_{rss} | Reverse Transfer Capacitance | | 40 | 65 | 90 | pF |
| R_g | Gate resistance | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$ | 3.5 | 7.5 | 11.5 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| $Q_g(10\text{V})$ | Total Gate Charge | $V_{GS}=-10\text{V}, V_{DS}=-15\text{V}, I_D=-5\text{A}$ | 7.4 | 9.2 | 11 | nC |
| $Q_g(4.5\text{V})$ | Total Gate Charge | | 3.7 | 4.6 | 6 | nC |
| Q_{gs} | Gate Source Charge | | 1.3 | 1.6 | 1.9 | nC |
| Q_{gd} | Gate Drain Charge | | 1.3 | 2.2 | 3.1 | nC |
| $t_{\text{D}(\text{on})}$ | Turn-On Delay Time | $V_{GS}=-10\text{V}, V_{DS}=-15\text{V}, R_L=3\Omega, R_{\text{GEN}}=3\Omega$ | | 7.5 | | ns |
| t_r | Turn-On Rise Time | | | 5.5 | | ns |
| $t_{\text{D}(\text{off})}$ | Turn-Off Delay Time | | | 19 | | ns |
| t_f | Turn-Off Fall Time | | | 7 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=-5\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | 8.8 | 11 | 13 | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=-5\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | 4 | 5.3 | 6.4 | nC |

A. The value of R_{JJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ\text{C}$. The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=150^\circ\text{C}$, using $\leq 10\text{s}$ junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(\text{MAX})}=150^\circ\text{C}$. Ratings are based on low frequency and duty cycles to keep initial $T_J=25^\circ\text{C}$.

D. The R_{JJA} is the sum of the thermal impedance from junction to lead R_{JL} and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J(\text{MAX})}=150^\circ\text{C}$. The SOA curve provides a single pulse rating.

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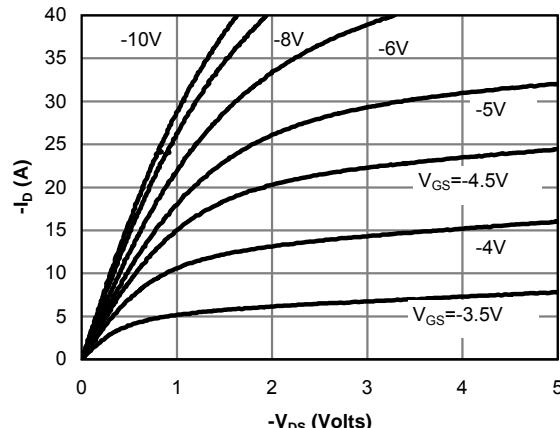
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


Fig 1: On-Region Characteristics (Note E)

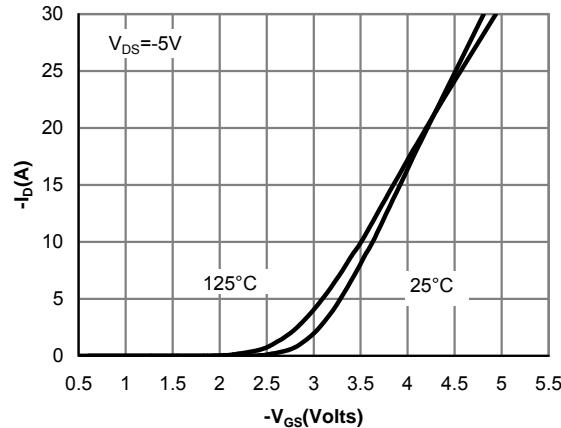


Figure 2: Transfer Characteristics (Note E)

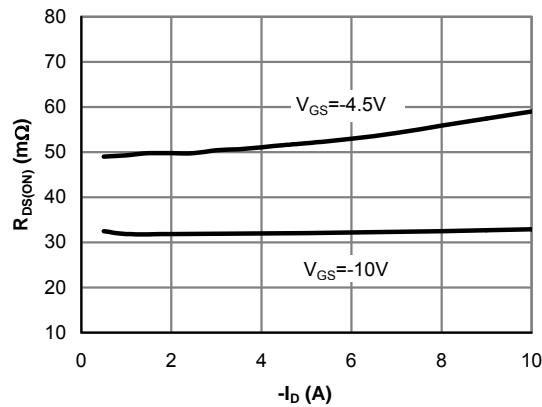


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

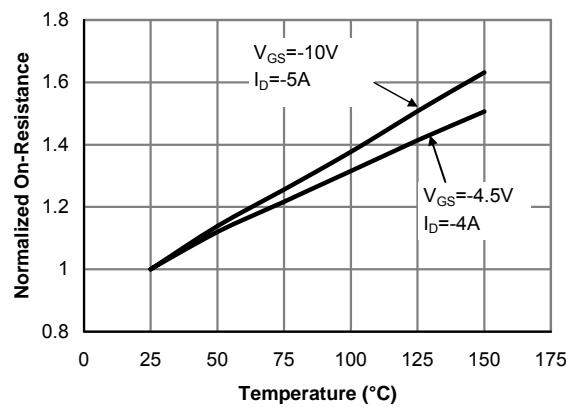


Figure 4: On-Resistance vs. Junction Temperature (Note E)

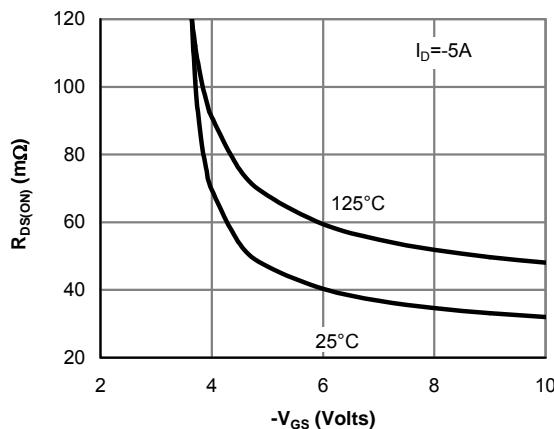


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

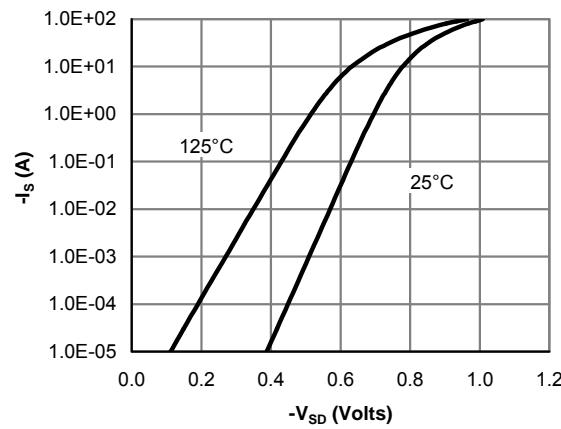


Figure 6: Body-Diode Characteristics (Note E)

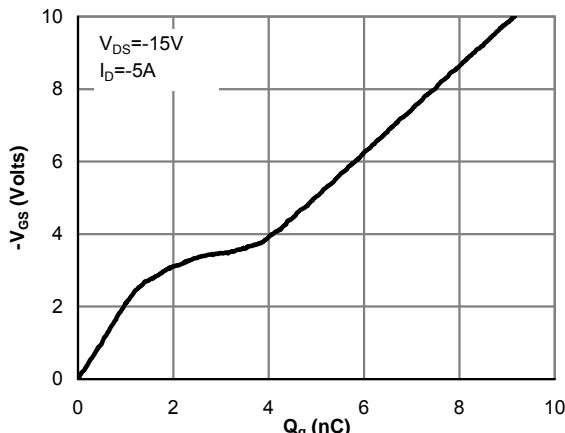
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


Figure 7: Gate-Charge Characteristics

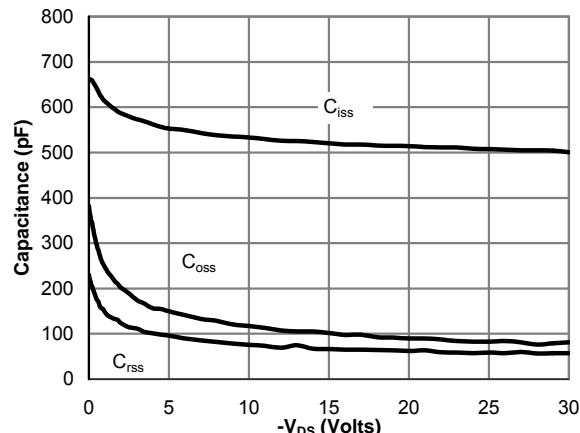


Figure 8: Capacitance Characteristics

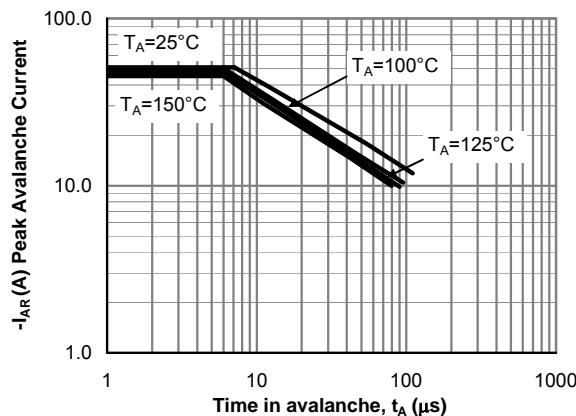


Figure 9: Single Pulse Avalanche capability (Note C)

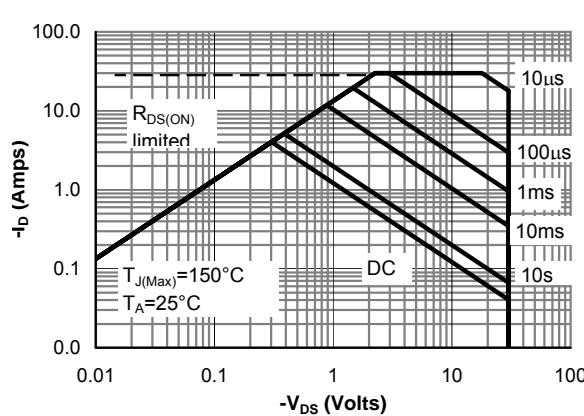


Figure 10: Maximum Forward Biased Safe Operating Area (Note F)

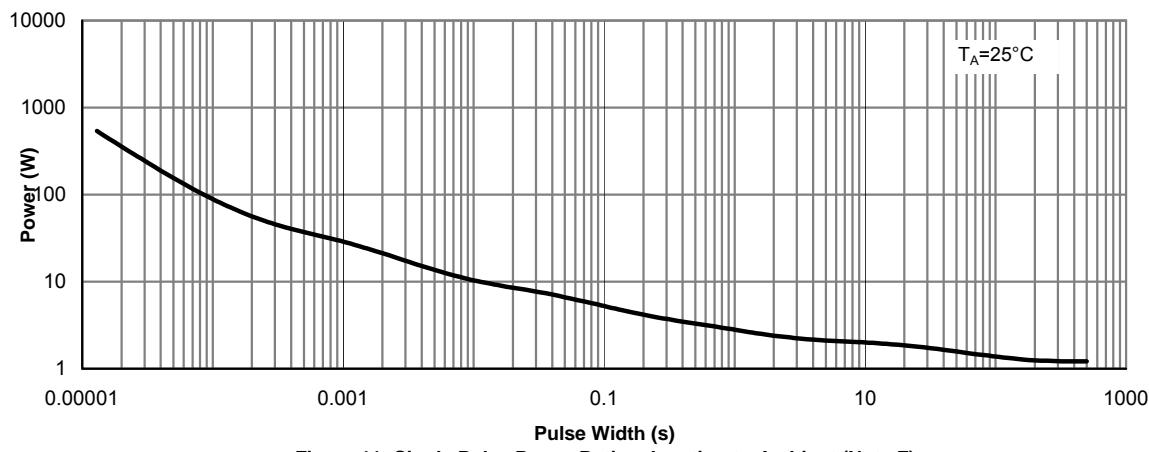


Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)

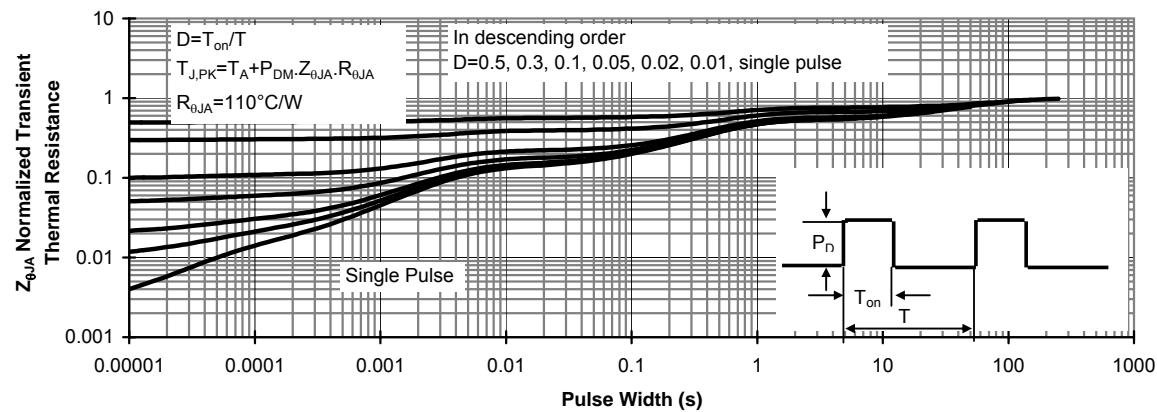
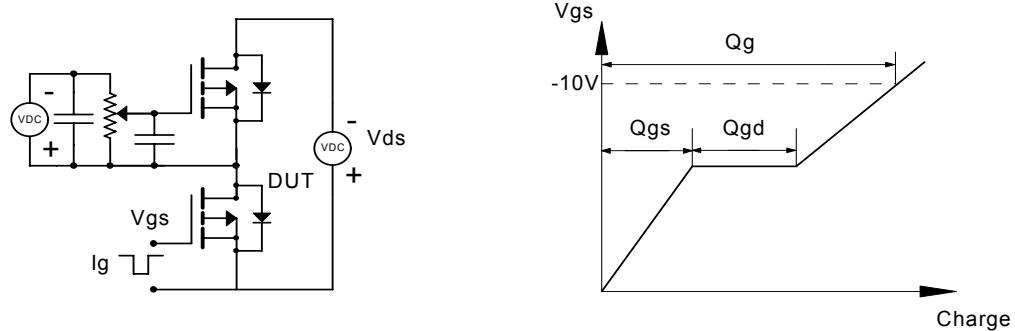
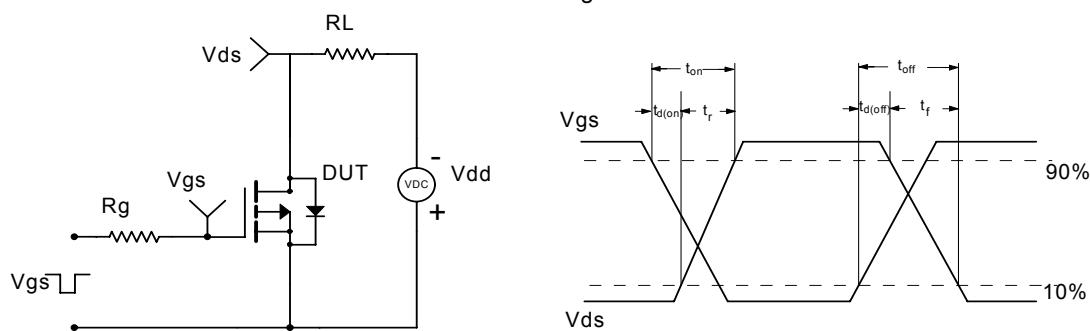
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


Figure 12: Normalized Maximum Transient Thermal Impedance (Note F)

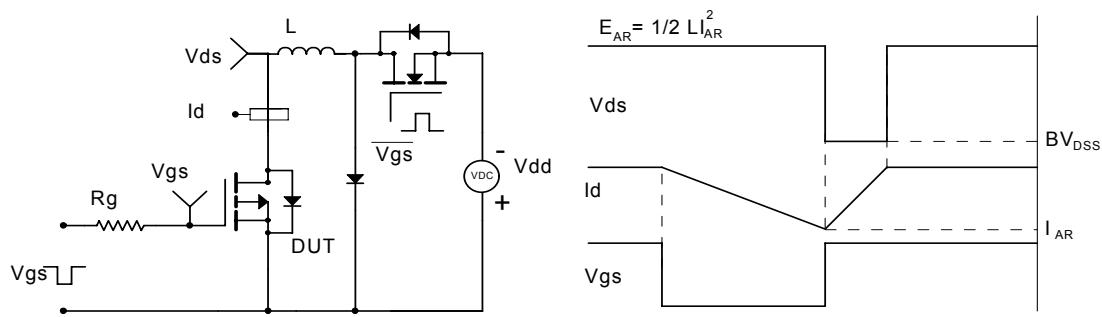
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

